

**Search Notes**

Application/Control No.

10/722,837

Examiner

Ahmed M. Farah

Applicant(s)/Patent under  
Reexamination

WANG ET AL.

Art Unit

3735

**SEARCHED**

Class	Subclass	Date	Examiner
606	10-18, 32-52	3/6/2006	AF
607	88,89,96,		
704	3,4,233		
	200-210		
	251-255		
	270,275		
600	101-104		
	106-109		
	114,118		
901	2-9,30		
	36,46		
414	02		
381	110		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search Histor Printout		3/6/2006	AF

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Search; and EAST search: Classification (IS&R); and Text (BRS)	3/6/2006	AF
Searched Data Basis: USPAT; USPGPUB; EPO; JPO; DERWENT; and IBM_TDB.	3/6/2006	AF
See the attached "Search History."	3/6/2006	AF